Electronic Supplementary Material (ESI) for RSC Advances. This journal is © The Royal Society of Chemistry 2017

#### **Supporting Information for**

Designing Thiophene-fused benzoxadizole as an Acceptor to Build a

Narrow Bandgap Polymer for All-Polymer Solar Cells

Yang Yang<sup>1</sup>, Jiacheng Wang<sup>1</sup>, Xiaowei Zhan<sup>2</sup>\*, Xingguo Chen<sup>1</sup>\*

<sup>1</sup>Hubei Key Laboratory on Organic and Polymeric Opto-electronic Materials, College of Chemistry and Molecular Sciences, Wuhan University, Wuhan 430072, China.

Email: xgchen@whu.edu.cn

<sup>2</sup>Department of Materials Science and Engineering, College of Engineering, Peking University, Beijing 100871, China. Email: <a href="mailto:xwzhan@pku.edu.cn">xwzhan@pku.edu.cn</a>.

#### **Device fabrication**

ΑII polymer cells were fabricated with solar structure ITO/PEDOT:PSS/P3HT:PBXT-IDT/Ca/Al. The patterned indium tin oxide (ITO) glass (sheet resistance= 10  $\Omega$   $\square$ <sup>-1</sup>) was pre-cleaned in an ultrasonic bath of deionized water, acetone and isopropanol, followed by oxygen plasma treatment (25 min) in an ultraviolet- ozone chamber (Jelight Company, USA). A thin layer (30 nm) of poly(3,4-ethylenedioxythiophene):poly(styrene sulfonate) (PEDOT:PSS, Baytron PVP AI 4083, Germany) was spin-coated onto the ITO glass at 4000 rpm and baked subsequently at 150 °C for 20 min. The mixture of P3HT:PBXT-IDT in chlorobenzene solvent (14 mg mL<sup>-1</sup> in total) with or without chloroform was spin-coated on a PEDOT:PSS layer to form an active layer. Calcium (ca. 20 nm) and aluminium (ca. 80 nm) layers were deposited onto the active layer in a vacuum at a pressure of ca. 5.0  $\times$  10<sup>-5</sup> Pa to form the negative electrode. The active area of the device was 4mm<sup>2</sup>. The current density-voltage (J-V) characteristics were measured on a computercontrolled B2912A Precision Source/Measure Unit (Agilent Technologies). A XES-70S1 (SAN-El Electric Co., Ltd) solar simulator (AAA grade, 70 × 70 mm<sup>2</sup> photobeam size) coupled with AM 1.5 G solar spectrum filters was used as the light

source, and the optical power at the sample was 100 mW/cm². A 2 × 2 cm² monocrystalline silicon reference cell (SRC-1000-TC-QZ) was purchased from VLSI Standards Inc. A Solar Cell Spectral Mrasurement System QE-R3011 (Enlitech Co., Ltd) was used for the EQE spectrum measurement. The light intensity at each wavelength was calibrated using a standard single crystal Si photovoltaic cell. The hole mobility and electron mobility were measured using the structure: ITO/PEDOT:PSS/P3HT:PBXT-IDT/Au and ITO/titanium (diisopropoxide) bis(2,4-pentanedionate) (TIPD)/P3HT:PBXT-IDT/Al respectively. And the mobility was extracted by fitting the curremt J–V curves using the Mott–Gurney relationship (space charge limited current).

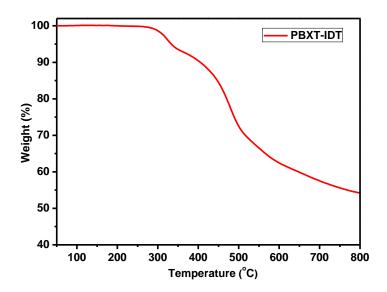
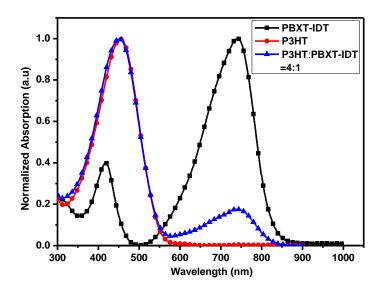


Figure S1. The TGA curve of PBXT-IDT



**Figure S2.** Absorption spectra of PBXT-IDT, P3HT and P3HT:PBXT-IDT (4:1,p/n) in chlorobenzene

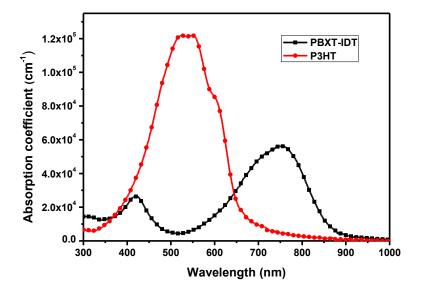


Figure S3. The absorption spectra of PBXT-IDT and P3HT in thin films

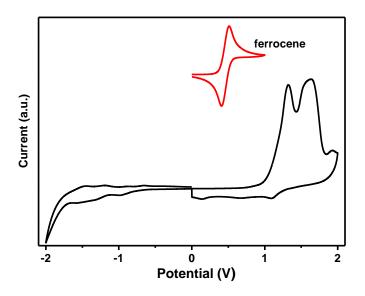
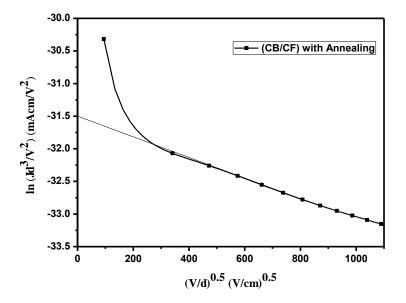
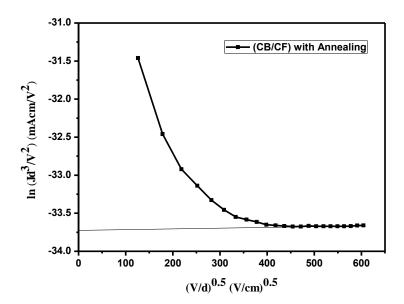


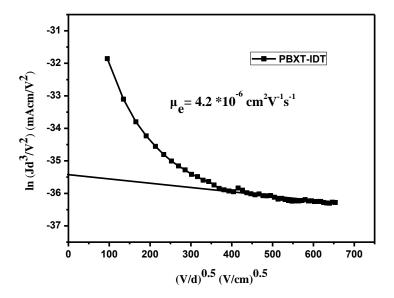
Figure S4. The CV curve of PBXT-IDT



**Figure S5.**  $Ln(JL^3/V^2)$  vs  $(V/L)^{0.5}$  of plot of the all-PSCs based on P3HT / PBXT-IDT for the hole mobility measurement.



**Figure S6.**  $Ln(JL^3/V^2)$  vs  $(V/L)^{0.5}$  of plot of the all-PSCs based on P3HT / PBXT-IDT for the electron mobility measurement.



**Figure S7.**  $Ln(JL^3/V^2)$  vs  $(V/L)^{0.5}$  of plot of the pure PBXT-IDT film for the electron mobility measurement.

**Table S1.** OPV performances based on PBXT-IDT and P3HT with different p/n ratio.

Polymer	p/n	$V_{OC}$	$J_{SC}$	FF	PCE
		(V)	( mA cm <sup>-2</sup> )	(%)	(%)
PBXT-IDT	1:1	0.83	1.15	33.59	0.32
PBXT-IDT	2:1	0.86	1.07	45.09	0.42
PBXT-IDT	3:1	0.88	1.18	44.29	0.46
PBXT-IDT	4:1	0.88	1.41	43.81	0.54
PBXT-IDT	5:1	0.83	1.19	37.01	0.36

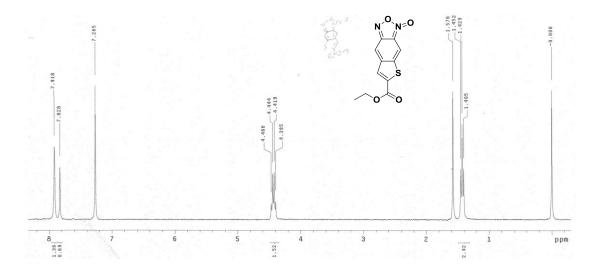
**Table S2.** OPV performances based on P3HT/PBXT-IDT (4:1, w/w) at different thermal annealing temperature.

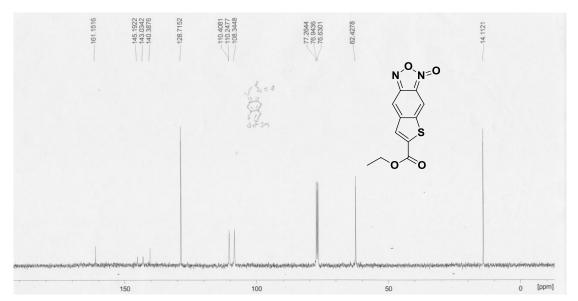
Polymer	Annealing	$V_{\sf OC}$	$J_{SC}$	FF	PCE
	(°C)	(V)	( mA cm <sup>-2</sup> )	(%)	(%)
PBXT-IDT	90	0.83	2.27	40.22	0.76
PBXT-IDT	100	0.79	2.24	47.75	0.85
PBXT-IDT	110	0.76	2.15	41.30	0.68

**Table S3.** OPV performances based on P3HT/PBXT-IDT (4:1, w/w) with different volume of chloroform with thermal annealing at 100 °C.

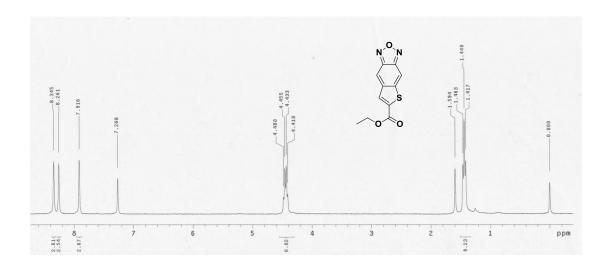
Polymer	Chloroform	V <sub>oc</sub>	$J_{SC}$	FF	PCE	
	(%)	(V)	( mA cm <sup>-2</sup> )	(%)	(%)	
PBXT-IDT	5	0.82	2.41	44.27	0.87	
PBXT-IDT	10	0.84	2.95	43.86	1.09	
PBXT-IDT	20	0.83	2.26	47.74	0.90	

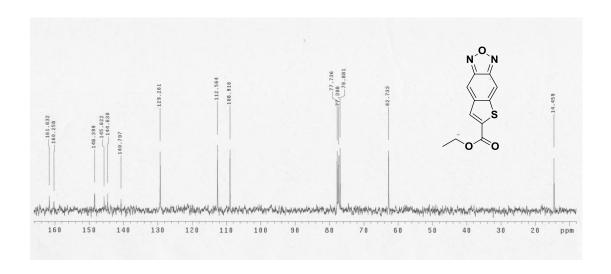
# <sup>1</sup>H NMR and <sup>13</sup>C NMR spectra of compound 3



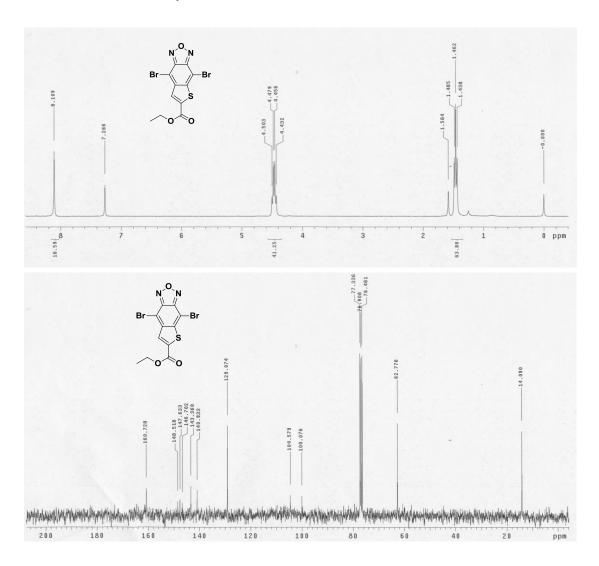


<sup>1</sup>H NMR and <sup>13</sup>C NMR spectra of BXT





### <sup>1</sup>H NMR and <sup>13</sup>C NMR spectra of di-Br-BXT



# <sup>1</sup>H NMR and <sup>13</sup>C NMR spectra of polymer PBXT-IDT

